## Rapid Communication

## Preparation of Tl-Ba-Ca-Cu-O Thin Films by Diffusion of Tl into Laser Evaporated Ba<sub>2</sub>Ca<sub>2</sub>Cu<sub>3</sub>O<sub>x</sub> Films

H. Lengfellner, J. Betz, and K. F. Renk

Fakultät Physik, Universität, D-8400 Regensburg, Fed. Rep. Germany

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Atstract. Preparation of superconducting Tl-Ba-Ca-Cu-O thin films by diffusion of Tl into laser evaporated Ba<sub>2</sub>Ca<sub>2</sub>Cu<sub>3</sub>O<sub>x</sub> thin films is reported. From a sintered Ba<sub>2</sub>Ca<sub>2</sub>Cu<sub>3</sub>O<sub>x</sub> bulk sample we prepared using a pulsed Nd:YAG laser, Ba-Ca-Cu-O thin films on sapphire and SrTiO<sub>3</sub> single-crystal substrates. Subsequently the films were loaded with Tl by simultaneously annealing the films together with a sintered Tl<sub>2</sub>Ba<sub>2</sub>Ca<sub>2</sub>Cu<sub>3</sub>O<sub>10</sub> sample both enclosed in a small stainless steel box; in our procedure Tl contamination was reduced to a minimum. T<sub>c</sub> values near 100 K and critical currents of 5·10<sup>3</sup> A/cm<sup>2</sup> at 77 K were obtained.

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After the discovery of superconductivity in Tl-Ba-Ca-Cu-O compounds [1], thin films of this material have been obtained by electron beam evaporation [2] and sputtering techniques [3-5]; critical currents of 10<sup>4</sup>-10<sup>5</sup> A/cm<sup>2</sup> at 77 K have been reported [2-5]. Tl-Ba-Ca-Cu-O films have also been prepared by rf sputtering of a Ba-Ca-Cu-O film and a subsequent heat treatment for diffusion of Tl into the film [6]. As a Tl source a piece of metallic Tl was used, and zero resistance was reached at about 75 K [6]. We have developed a similar film preparation method, using, however, a laser evaporation technique and a modified Tl diffusion procedure. We obtained films with a superconducting transition temperature near 100 K and critical currents of about  $5.10^3$  A/cm<sup>2</sup> at 77 K.

For the preparation of Tl-Ba-Ca-Cu-O thin films used was made of a standard sintered  $Tl_2Ba_2Ca_2Cu_3O_{10}$  sample and a sintered  $Ba_2Ca_2Cu_3O_{x}$  sample. The (nonmetallic)  $Ba_2Ca_2\cdot Cu_3O_{x}$  sample was prepared by using and grinding appropriate amounts of  $CaCO_3$ ,  $BaCO_3$  and CuO, pressing to a pellet (with 2 tons/cm²) and sintering at 900°C for 10 h in oxygen atmo-

sphere. From this pellet, a thin film was laser evaporated onto sapphire and SrTiO<sub>2</sub> single crystal substrates (heated to 400°C). The substrate was located in the evaporation cone at a distance of about 2 cm from the pellet. The slightly focused beam (diameter: ~2mm) of a pulsed Nd: YAG laser (pulse duration: 50ns, pulse energy: 200mJ) was directed onto the slowly rotating target pellet mounted in a vacuum system (5·10<sup>-5</sup> Torr during evaporation). Material from the target evaporated perpendicular to the target surface. Our arrangement is described in more detail elsewhere [7]. In the next preparation step the film and a Tl<sub>2</sub>Ba<sub>2</sub>Ca<sub>2</sub>Cu<sub>3</sub>O<sub>10</sub> bulk sample were placed in a small stainless steel box (3×2×2cm<sup>3</sup>); a stainless steel ring (diameter: 10mm, thickness: 1mm) served as a spacer between film and bulk sample. The (closed) box was put into a preheated tube furnace (at 880°C) for 5 min and then taken out and quickly cooled to room temperature. Our film had a diameter of about 6 mm and a thickness of about 1  $\mu$ m (after 5000 laser shots). We note here that we also tried the Tl-loading step with a small amount of Tl<sub>2</sub>O<sub>3</sub> powder instead of the Tl<sub>2</sub>Ba<sub>2</sub>Ca<sub>2</sub>Cu<sub>3</sub>O<sub>10</sub> bulk

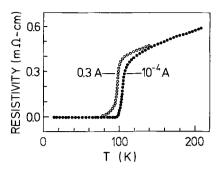


Fig.1. Resistivity versus temperature for a Tl-Ba-Ca-Cu-O film on SrTiO<sub>3</sub>, for currents of 10<sup>-4</sup> A and 0.3 A, respectively

sample, but did not succeed in obtaining superconducting films.

Conductivity and critical current measurements were performed by a standard four-point technique; contacts were made with silver epoxy paint. The resistivity at room temperature was about 0.7 m $\Omega$ ·cm for a film on a (100) SrTiO<sub>3</sub> substrate. The resistivity decreased almost linearly between 300 and 150 K, a deviation from this behavior was observed below 140 K (Fig.1). We obtained T<sub>c</sub> values of 100-117 K (10-90%) for the resistive transition, with T<sub>c</sub>R=0 at 96 K. Similar results with respect to resistivity values have been obtained for a film on a sapphire substrate; T<sub>c</sub>R=0 was 93 K for this film.

The resistivities were measured with small currents (10<sup>-4</sup> A). For a measurement of the critical current, we increased the current through the film. In Fig.1, the slope of the resistivity obtained with a current of 0.3 A (dotted line) is

also shown. The film showed non-zero resistance for temperatures above 77 K. We increased the current, with the film immersed in liquid helium, up to 0.5 A. At a higher current the film was destroyed, probably due to imcomplete cooling of the contact regions. From these observations we obtained lower limits for the critical currents of about 5·10<sup>3</sup> A/cm<sup>2</sup> at 77 K and of 10<sup>4</sup> A/cm<sup>2</sup> at 4.2 K.

In conclusion, we have shown that Tl-Ba-Ca-Cu-O films with high values for  $T_c$  and for the critical current can be produced using a laser evaporation technique for the production of a Tl-free Ba-Ca-Cu-O film and a subsequent Tl diffusion step to load the film with Tl. The use of  $Tl_2Ba_2Ca_2Cu_3O_{10}$  bulk samples as a Tl source in an enclosed environment seems to be important for the diffusion procedure.

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